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Dr. Sadid Muneer

Associate Professor, Dept. of EEE & Undergraduate Coordinator

ROOM: 512 (D) PABX: 3312 Email: sadidmuneer@eee.uiu.ac.bd sadidmuneer@eee.uiu.ac.bd +8801714078421 * Home * Faculty Profiles

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Biography

Associate Professor & Undergraduate Program Coordinator

Education

	Ph.D. in Electrical Engineering (Nanoelectronics)University of Connecticut (UConn)Storrs, CT, USA, March 2019
	B. Sc. in Electrical & Electronic EngineeringBangladesh University of Engineering & Technology (BUET)Dhaka, Bangladesh, June 2007
### Research Interest	
### Thermoelectric Effects in Nanoscale Transport	
Asymmetric melting of Si micro-wire under electrical stress. Generation-transport- recombination (GTR) of minority carriers is one of the contributors of this thermoelectric effect (More…).	
### Phase Change Memory: Novel Device Structures and Electrothermal Finite Element Simulation	

Design of vacuum-insulated self-aligned nanowire phase-change memory devices to minimize the current requirement and suppress crosstalk (More…).	
### Material Parameter Extraction from Nanoscale Device Measurements	
Effective activation energy from room temperature to melt calculated from the measured resistivity of metastable amorphous GST (More…).	
### Publication	
Full publication list here.	
### Journal:	
9. S. Muneer , M. A. H. Chowdhury, M. Kabiruzzaman, S. Shahnewaz, N. Noor, and M. Hossain, "Thermal Confinement by Monolayer MoS2 for Reduced RESET Current in Phase Change Memory Pillar Cells.†in ACS Applied Electronic Materials, vol. , pp. , Jun 2024, doi: 10.1021/acsaelm.4c00721.	
8. S. Muneer , G. Bakan, A. Gokirmak, and H. Silva, "Incorporation of Generation-Transport-Recombination (GTR) in Semiconductor Simulations.†in <i>Journal of Applied Physics</i> , vol. 129, pp. 055702-1:13, Feb 2021, doi: 10.1063/5.0037411.	
7. N. Noor, S. Muneer , R. S. Khan, A. Gorbenko, L. Adnane, M. T. B. Kashem, J. Scoggin, F. Dirisaglik, A. Cywar, A. Gokirmak, and H. Silva, "Reset Variability in Phase Change Memory for Hardware Security Applications.†in <i>IEEE Transactions on Nanotechnology</i> , vol. 20, pp. 75-82, Nov 2020, doi: 10.1109/TNANO.2020.3041400.	
6. N. Noor, S. Muneer , R. S. Khan, A. Gorbenko, and H. Silva, "Enhancing Programming Variability in Multi-bit Phase Change Memory Cells for Security,†in <i>IEEE Transactions on Nanotechnology</i> , vol. 19, 820-828, Nov 2020, doi: 10.1109/TNANO.2020.3037097.	
5. N. Noor, S. Muneer , R. S. Khan, A. Gorbenko, and H. Silva, "Amorphized length and variability in phase-change memory line cells,† <i>Beilstein Journal of Nanotechnology</i> 11, no. 1, 1644-1654, Oct 2020, doi: 10.3762/bjnano.11.147.	
4. S. Muneer , J. Scoggin, F. Dirisaglik, L. Adnane, A. Cywar, G. Bakan, K. Cil, C. Lam, H. Silva, and A. Gokirmak, "Activation Energy of Metastable Amorphous Ge2Sb2Te5 from Room Temperature to Melt.† <i>AIP Advances</i> , 8, issue 6, 065314-1:8, Jun 13, 2018, doi: 10.1063/1.5035085.	
3. A. Deschenes, S. Muneer , M. Akbulut, A. Gokirmak, and H. Silva, "Analysis of Self-heating of Thermally Assisted Spin-transfer Torque Magnetic Random Access Memory.† <i>Beilstein Journal of Nanotechnology</i> , 7, 1676–1683, Nov 11, 2016, doi: 10.3762/bjnano.7.160.	
2. F. Dirisaglik, G. Bakan, Z. Jurado, S. Muneer , M. Akbulut, J. Rarey, L. Sullivan, M. Wennberg, A. King, L. Zhang, R. Nowak, C. Lam, H. Silva, and A. Gokirmak, "High Speed, High Temperature Electrical Characterization of Phase Change Materials: Metastable Phases, Crystallization Dynamics, and Resistance drift.† <i>Nanoscale</i> , 7, issue 40, 16625-16630, Sep 22, 2015, doi: 10.1039/C5NR05512A.	
1. S. Muneer , A. Gokirmak, and H. Silva, "Vacuum-Insulated Self-aligned Nanowire Phase-change Memory Devices.† <i>IEEE Transactions on Electron Devices (TED)</i> , 62, issue 5, 1668-1671, Apr 20, 2015, doi: 10.1109/TED.2015.2414716.	
### Book Chapter:	
1. R. S. Khan, N. Noor, C. Jin, J. Scoggin, Z. Woods, S. Muneer , A. Ciardullo, P. H. Nguyen, A. Gokirmak, M. van Dijk, and H. Silva, "Phase Change Memory and Its Applications in Hardware Security.†in: Security Opportunities by Nano Devices and Emerging Technologies, <i>CRC Press</i> , 2017, doi: 10.1201/9781315265056.	
### E-print:	

1. R. S. Khan, N. Kanan, C. Jin, J. Scoggin, N. Noor, S. Muneer , F. Dirisaglik, P. H. Nguyen, H. Silva, M. van Dijk, and A. Gokirmak, "Intrinsically Reliable and Lightweight Physical Obfuscated Keys.†arXiv preprint arXiv:1703.07427, 2017 (link).	
### Conference Proceedings:	
6. M. T. B. Kashem, S. Muneer , L. Adnane, F Dirisaglik, A. Gokirmak and H. Silva, "Calculation of the Energy Band Diagram and Estimation of Electronic Transport Parameters of Metastable Amorphous Ge2Sb2Te5.†Talk & proceeding, 241st ECS Meeting, Vancouver, Canada, May 29, 2022 – June 2, 2022, doi: 10.1149/10801.0029ecst.	
5. A. Gorbenko, N. Noor, S. Muneer , R. S. Khan, F. Dirisaglik, A. Cywar, B. Shakya, D. Forte, M. v. Dijk, A. Gokirmak, H. Silva, "Resistance Drift and Crystallization in Suspended and On-oxide Phase Change Memory Line Cells.†Talk, <i>19th IEEE Conference on Nanotechnology (IEEE-NANO)</i> , ThOBO5.1, Parisian Macao, Macau, China, Jul 22-26, 2019, doi: 10.1109/NANO46743.2019.8993884.	
4. N. Noor, R. S. Khan, S. Muneer , H. Silva, "Tamper Evidence of SEM Imaging Attack in Phase Change Memory Nanodevices.†Talk & proceeding, <i>19th IEEE Conference on Nanotechnology (IEEE-NANO)</i> , ThOBO4.3, Parisian Macao, Macau, China, Jul 22-26, 2019, doi: 10.1109/NANO46743.2019.8993903.	
3. R. S. Khan, N. Noor, C. Jin, S. Muneer , F. Dirisaglik, A. Cywar, P. H. Nguyen, M. v. Dijk, A. Gokirmak, H. Silva, "Exploiting Lithography Limits for Hardware Security Applications.†Talk & proceeding, <i>19th IEEE Conference on Nanotechnology (IEEE-NANO)</i> , WeOAO1.3, Parisian Macao, Macau, China, Jul 22-26, 2019 (nominated for best paper award), doi: 10.1109/NANO46743.2019.8993902.	
2. F. Dirisaglik, G. Bakan, S. Muneer , N. Williams, M. Akbulut, H. Silva, and A. Gokirmak, "Electrical Pump-Probe Characterization Technique for Phase Change Materials.†Talk & proceeding, <i>74th Device Research Conference (DRC)</i> , Newark, Delaware, USA, Jun 19-22, 2016, doi: 10.1109/DRC.2016.7548508.	
1. N. Noor and S. Muneer , "Concentrating Solar Power (CSP) and Its Prospect in Bangladeshâ€, 1st International Conference on the Developments in Renewable Energy Technology (ICDRET), Dhaka, Bangladesh, December 2009, doi: 10.1109/ICDRET.2009.5454207.	
### Conference Talks and Posters:	
36 talks and posters in prestigious conferences, such as:	
* – Materials Society Meeting (MRS), USA.	
* – Applied Physics Society (APS) Meeting, USA.	
* â€" European Phase Change and Ovonic Symposium (E/PCOS), Grenoble, France.	

Full list of talks and posters is here.

Experience

Dec 18, 2022 to date	Associate Professor, Department of Electrical & Electronic Engineering, United International University (UIU)
Sep 14, 2019 to date	Undergraduate Program Coordinator, Department of Electrical and Electronic Engineering, United International University (UIU)
Dec 22, 2019 to Dec 17, 2022	Assistant Professor, Department of Electrical & Electronic Engineering, United International

	University (UIU)
Apr, 2012 to Mar, 2019 and Aug, 2011 to Dec, 2011	Graduate Assistant, Department of Electrical & Computer Engineering, University of Connecticut, USA
* Research Assistant, Fall 2011, Summer & Fall 2012, Spring, Summer & Fall 2013-2018, Spring 2019 – Nanoelectronics Lab	
* Teaching Assistant, Spring 2013, 2017, 2018 & Summer 2013: ECE 2001W – Electrical Circuits, Fall 2015, 2016, 2017: ECE 4225 – Electron Device Design and Characterization	
* Grader, Fall 2013: ECE 2001W – Electrical Circuits, Fall 2011 & Fall 2012: ECE 3001 – Electromagnetic Fields & Waves	

Oct 08, 2008 to Dec 21, 2019 | Lecturer, Department of Electrical & Electronic Engineering, United International University (UIU)

May 27, 2007 to Oct 7, 2008 | SI Solution Integrator, Ericsson Bangladesh Limited

Teaching

Summer 2024 * EEE 2101: Electronics II * EEE 2104: Electronics Laboratory

Spring 2024 * EEE 2101: Electronics II * EEE 2104: Electronics Laboratory

Fall 2023 * EEE 2101: Electronics I * EEE 2103: Electronics II * EEE 3208: Power Electronics Laboratory

Summer 2023 * EEE 2101: Electronics I * EEE 2103: Electronics II * EEE 2104: Electronics Laboratory

Spring 2023 * EEE 2101: Electronics I

Fall 2022 * EEE 2101: Electronics I * EEE 2104: Electronics Laboratory * EEE 3308: Communication Laboratory

Summer 2022 * EEE 2101: Electronics I * EEE 2104: Electronics Laboratory * EEE 2000: Simulation Laboratory

Spring 2022 * EEE 2301: Signals and Linear Systems

Fall 2021 * EEE 2301: Signals and Linear Systems * EEE 3107: Electrical Properties of Materials

Summer 2021 * EEE 3107: Electrical Properties of Materials * EEE 2000: Simulation Laboratory * EEE 4903: Capstone Project III

Spring 2021 * EEE 2301: Signals and Linear Systems * EEE 3107: Electrical Properties of Materials * EEE 4903: Capstone Project III

Fall 2020 * EEE 2301: Signals and Linear Systems * EEE 3107: Electrical Properties of Materials

Summer 2020 * EEE 2301: Signals and Linear Systems * EEE 3107: Electrical Properties of Materials

Spring 2020 * EEE 211: Signals and Linear Systems (Sec A) * EEE 211: Signals and Linear Systems (Sec B)

Fall 2019 * EEE 211: Signals and Linear Systems * EEE 301: Electrical Properties of Materials

Professional Contribution

Director: * International Relations and Industry Liasson, Board of Accreditation for Engineering and Technical Education (BAETE)

Membership: * IEEE (Institute of Electrical and Electronics Engineers), since 2007 * IEB (The Institution of Engineers, Bangladesh)

Journal Reviewer: * Thin Solid Films

Conference Reviewer: * NMDC 2024 (Salt Lake City, Utah, USA) * ICDRET 2024 (UIU, Dhaka, Bangladesh) * ICTP 2023 (BUET, Dhaka, Bangladesh) * IC4IR 2021 (Dhaka, Bangladesh) * ICREST 2021 (AIUB, Dhaka, Bangladesh) * ICAICT 2020 (UIU, Dhaka, Bangladesh) * IEEE NANO 2019 (Macau, China)

Contacts

Email: sadidmuneer@eee.uiu.ac.bd Room: 512 (D), United International University PABX: +8809604 848848, extension 3312 LinkedIn: https://bd.linkedin.com/in/sadid-muneer-09b6364 Google Scholar: https://scholar.google.com/citations?user=-jgjytMAAAAJ&hl=en

Resources

- An effective tutorial on Python: https://youtu.be/jFCNu1-Xdsw
- ABACUS (Assembly of Basic Applications for Coordinated Understanding of Semiconductors): https://nanohub.org/wiki/EduSemiconductor2

Publication

Journal Papers

2024## Thermal Confinement by Monolayer MoS2 for Reduced RESET Current in Phase Change Memory Pillar Cells Publication: ACS Applied Electronic Materials Author List: Sadid Muneer, Md. Kabiruzzaman, Nafisa Noor, Muhammad Aminul Haque Chowdhury, Mainul Hossain, Shafat Shahnewaz 2022## (Digital Presentation) Calculation of the Energy Band Diagram and Estimation of Electronic Transport Parameters of Metastable Amorphous Ge2Sb2Te5 Publication: ECS Transactions Author List: Md Tashfiq Bin Kashem, Ali Gokirmak, Helena Silva, Faruk Dirisaglik, Sadid Muneer, Lhacene Adnane 2021## Incorporation of GTR (generationâ€"transportâ€"recombination) in semiconductor simulations Publication: Journal of Applied Physics Author List: Sadid Muneer, Gokhan Bakan, Ali Gokirmak, Helena Silva 2020## Amorphized length and variability in phase-change memory line cells Publication: Beilstein Journal of Nanotechnology Author List: Nafisa Noor, Anna Gorbenko, Raihan Sayeed Khan, Helena Silva, Sadid Muneer

Enhancing Programming Variability in Multi-Bit Phase Change Memory Cells for Security

Publication: IEEE Transactions on Nanotechnology Author List: Nafisa Noor, Anna Gorbenko, Raihan Sayeed Khan, Sadid Muneer, Helena Silva

Reset Variability in Phase Change Memory for Hardware Security Applications

Publication: IEEE Transactions on Nanotechnology Author List: Nafisa Noor, Raihan Sayeed Khan, Adam Cywar, Anna Gorbenko, Sadid Muneer, Lhacene Adnane, Ali Gokirmak, Faruk Dirisaglik, Helena Silva, Jake Scoggin, Md. Tashfiq Bin Kashem

Conference Papers

2024## Effects of Cell Aspect Ratio and Applied Pulse Parameters on Resistance Drift in Ge2Sb2Te5 PCM Nanodevices Phase Change Memory Conference: 2024 IEEE Nanotechnology Materials and Devices Conference (NMDC) Author List: Tasneem Mazhar, Sadid Muneer, Nafisa Noor

Finite Element Simulations of Phase Change Memory Devices Using Semiconductor Physics

Phase Change Memory Conference: 2024 IEEE Nanotechnology Materials and Devices Conference (NMDC) Author List: Sadid Muneer, Nafisa Noor

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